HIGH-SPEED 3.3V 128/64K x 36 SYNCHRONOUS DUAL-PORT STATIC RAM WITH 3.3V OR 2.5V INTERFACE

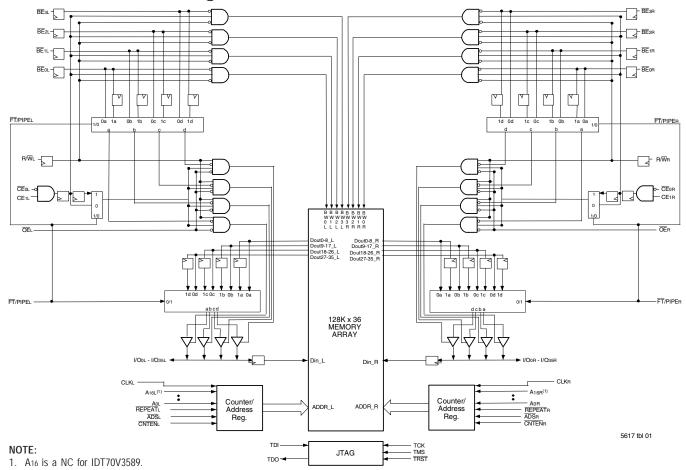
70V3599/89S

Features:

- True Dual-Port memory cells which allow simultaneous access of the same memory location
- High-speed data access
 - Commercial: 3.6ns (166MHz)/4.2ns (133MHz) (max.)
 - Industrial: 4.2ns (133MHz) (max.)
- Selectable Pipelined or Flow-Through output mode
- Counter enable and repeat features
- Dual chip enables allow for depth expansion without additional logic
- Full synchronous operation on both ports
 - 6ns cycle time, 166MHz operation (12Gbps bandwidth)
 - Fast 3.6ns clock to data out
 - 1.7ns setup to clock and 0.5ns hold on all control, data, and address inputs @ 166MHz
 - Data input, address, byte enable and control registers
 - Self-timed write allows fast cycle time

- Separate byte controls for multiplexed bus and bus matching compatibility
- Dual Cycle Deselect (DCD) for Pipelined Output mode
- LVTTL- compatible, 3.3V (±150mV) power supply for core
- LVTTL compatible, selectable 3.3V (±150mV) or 2.5V (±100mV) power supply for I/Os and control signals on each port
- Industrial temperature range (-40°C to +85°C) is available at 133MHz.
- Available in a 208-pin Plastic Quad Flatpack (PQFP), 208-pin fine pitch Ball Grid Array (fpBGA), and 256-pin Ball Grid Array (BGA)
- Supports JTAG features compliant with IEEE 1149.1
- Green parts available, see ordering information

Functional Block Diagram



NOVEMBER 2019



Description:

The IDT70V3599/89 is a high-speed 128/64K x 36 bit synchronous Dual-Port RAM. The memory array utilizes Dual-Port memory cells to allow simultaneous access of any address from both ports. Registers on control, data, and address inputs provide minimal setup and hold times. The timing latitude provided by this approach allows systems to be designed with very short cycle times. With an input data register, the IDT70V3599/89 has been optimized for applications having unidirectional

or bidirectional data flow in bursts. An automatic power down feature, controlled by $\overline{\text{CE}}_0$ and CE₁, permits the on-chip circuitry of each port to enter a very low standby power mode.

The 70V3599/89 can support an operating voltage of either 3.3V or 2.5V on one or both ports, controllable by the OPT pins. The power supply for the core of the device (VDD) remains at 3.3V.

Pin Configuration^(1,2,3,4,5)

A1 IO19L	A2 IO18L	A3 Vss	A4 TDO	A5 NC	A6 A16L ⁽¹	A7 A 12L	A8 A 8L	A9 BE1L	A10 VDD	A11 CLKL	A12 CNTENL	A13 A 4L	A14 A0L	A15 OPTL	A16 I/O17L	A17 Vss
B1 I/O20R	B2 Vss	B3 I/O18R	B4 TDI	B5 NC) B6 A13L	B7 A 9L	B8 BE2L	B9 CEol	B10 Vss	B11 ADSL	B12 A 5L	B13 A 1L	B14 Vss	B15 VDDQR	B16 I/O16L	B17 I/O15R
C1 VDDQL	C2 I/O19R	C3 Vddqr	C4 PL/FTL	C5 NC	C6 A 14L	C7 A10L	C8 BE3L	C9 CE1L	C10 Vss	C11 R/WL	C12 A 6L	C13 A 2L	C14 VDD	C15 I/O16R	C16 I/O15L	C17 Vss
D1 I/O22L	D2 Vss	D3 I/O21L	D4 I/O20L	D5 A 15L	D6 A 11L	D7 A 7L	D8 BEOL	D9 VDD	D10 OEL	D 11 REPEATL	D12 A 3L	D13 VDD	D14 I/O17R	D15 VDDQL	D16 I/O14L	D17 I/O14R
E1 I/O23L	E2 I/O22R	E3 Vddqr	E4 I/O21R					•	•	•		•	E14 I/O12L	E15 I/O13R	E16 Vss	E17 I/O13L
F1 VDDQL	F2 I/ O 23R	F3 I/O24L	F4 Vss										F14 Vss	F15 I/O12R	F16 I/O11L	F17 Vddqr
G1 I/O26L	G2 Vss	G3 I/O25L	G4 I/ O 24R				70\/	3599	9/89				G14 I/O9L	G15 Vddql	G16 I/O10L	G17 I/O11R
H1 VDD	H2 I/O26R	h3 Vddqr	H4 I/ O 25R				В	-208	(6)				H14 VDD	H15 IO 9R	H16 Vss	H17 I/O10R
J1 VDDQ	J2 Vdd	^{J3} Vss	J4 Vss					G208					J14 Vss	J15 Vdd	J16 Vss	J17 Vddqr
K1 I/O28R	K2 Vss	k3 I/O27R	K4 Vss			4	208-F Top	o Viev		\			K14 I/O7R	K15 VDDQ	K16 I/O8R	K17 Vss
L1 I/O29R	L2 I/O28L	l3 Vddqr	L4 I/O27L										L14 I/O6R	L15 I/O7L	L16 Vss	L17 I/O8L
M1 VDDQL	M2 I/O29L	мз I/OзоR	M4 Vss										M14 Vss	M15 I/O6L	M16 I/O5R	M17 Vddqr
N1 I/O31L	N2 Vss	N3 I/ O 31R	N4 I/O30L										N14 I/O3R	N15 Vddql	N16 I/O4R	N17 I/O5L
P1 I/O32R	P2 I/O32L	p3 Vddqr	P4 I/O35R	P5 TRST	P6 A16R ⁽¹⁾	P7 A 12R	P8 A 8R	P9 BE1R	P10 VDD	P11 CLKR	P12 CNTEN	P13 A 4R	P14 I/O2L	P15 I/O3L	P16 Vss	P17 I/O4L
R1 Vss	R2 I/O33L	R3 I/O34R	R4 TCK	R5 NC	R6 A 13R	R7 A 9R	R8 BE2R	R9 CE0R	R10 Vss	R11 ADSR	R12 A 5R	R13 A1R	R14 Vss	R15 Vddql	R16 I/O1R	R17 VDDQR
T1 I/O33R	T2 I/O34L	t3 Vddql	T4 TMS	T5 NC	T6 A 14R	T7 A 10R	T8 BE3R	T9 CE1R	T10 Vss	T11 R/WR	T12 A 6R	T13 A 2R	T14 Vss	T15 I/O0R	T16 Vss	T17 I/O2R
U1 Vss	U2 I/ O 35L	u3 PL/FTR	U4 NC	U5 A 15R	U6 A 11R	U7 A 7R	U8 BEor	U9 Vdd	U10 OEr	U11 REPEATR	U12 A 3R	U13 A 0R	U14 VDD	U15 OPTR	U16 I/Ool	U17 I/O1L

NOTES:

- 1. A₁₆ is a NC for IDT70V3589.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIL (0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 15mm x 15mm x 1.4mm with 0.8mm ball pitch.
- 6. This package code is used to reference the package diagram.
- 7. This text does not indicate orientation of the actual part-marking.

5617 drw 02c

Pin Configuration^(1,2,3,4,5) (con't.)

70V3599/89BC BC256⁽⁶⁾ BCG256⁽⁶⁾

256-Pin BGA Top View⁽⁷⁾

06/28/02

A1	A2	A3	A4	A5	A6	A7	A8	A9	A10	A11	A12	A13	A14	A15	A16
NC	TDI	NC	NC	A14L	A11L	A 8L	BE ₂ L	CE ₁ L	ŌĒL	CNTENL	A 5L	A 2L	A oL	NC	NC
B1	B2	B3	B4	B5	B6	B7	B8	B9	B10	B11	B12	B13	B14	B15	B16
I/O18L	NC	TDO	NC	A 15L	A 12L	A 9L	BE3L	CEoL	R/WL	REPEATL	A 4L	A 1L	VDD	I/O17L	NC
C1	C2	C3	C4	C5	C6	C7	C8	C9	C10	C11	C12	C13	C14	C15	C16
I/O18R	I/O19L	Vss	A16L ⁽¹⁾	A 13L	A10L	A 7L	BE1L	BEol	CLKL	ADSL	A 6L	A 3L	OPTL	I/O17R	I/O16L
D1	D2	D3	D4	D5	D6	D7	D8	D9	D10	D11	D12	D13	D14	D15	D16
I/ O 20R	I/O19R	I/ O 20L	PIPE/FTL	Vddql	VDDQL	VDDQR	Vddqr	Vddql	Vddql	VDDQR	VDDQR	VDD	I/O15R	I/O15L	I/O16R
E1	E2	E3	E4	E5	E6	E7	E8	E9	E10	E11	E12	E13	E14	E15	E16
I/O21R	I/O21L	I/O22L	VDDQL	Vdd	VDD	Vss	Vss	Vss	Vss	VDD	VDD	VDDQR	I/O13L	I/O14L	I/O14R
F1	F2	F3	F4	F5	F6	F7	F8	F9	F10	F11	F12	F13	F14	F15	F16
I/O23L	I/O22R	I/O23R	Vddql	VDD	Vss	V SS	Vss	Vss	Vss	Vss	VDD	VDDQR	I/O12R	I/O13R	I/O12L
G1	G2	G3	G4	G5	G6	G7	G8	G9	G10	G11	G12	G13	G14	G15	G16
I/ O 24R	I/O24L	I/ O 25L	VDDQR	Vss	Vss	V SS	Vss	Vss	Vss	Vss	Vss	VDDQL	I/O10L	I/O11L	I/O11R
H1	H2	H3	H4	H5	H6	H7	H8	H9	H10	H11	H12	H13	H14	H15	H16
I/O26L	I/O25R	I/O26R	Vddqr	V SS	Vss	V SS	Vss	Vss	Vss	Vss	Vss	VDDQL	I/O9R	IO 9L	I/O10R
J1	J2	J3	J4	J5	J6	J7	J8	^{J9}	J10	J11	J12	J13	J14	J15	J16
I/O27L	I/O28R	I/O27R	VDDQL	Vss	Vss	V SS	Vss	Vss	Vss	Vss	Vss	Vddqr	I/O8R	I/ O 7R	I/O8L
K1	K2	K3	K4	K5	K6	K7	K8	K9	K10	K11	K12	K13	K14	K15	K16
I/O29R	I/ O 29L	I/O28L	Vddql	Vss	Vss	V SS	Vss	Vss	Vss	Vss	Vss	VDDQR	I/O6R	I/O6L	I/O7L
L1	L2	L3	L4	L5	L6	L7	L8	L9	L10	L11	L12	L13	L14	L15	L16
I/O30L	I/O31R	I/O30R	VDDQR	Vdd	Vss	Vss	Vss	Vss	Vss	Vss	VDD	Vddql	I/O5L	I/O4R	I/O5R
M1	M2	M3	M4	M5	M6	M7	M8	M9	M10	M11	M12	M13	M14	M15	M16
I/O32R	I/O32L	I/O31L	VDDQR	VDD	VDD	Vss	Vss	Vss	Vss	VDD	Vdd	VDDQL	I/Озп	I/ О 3L	I/O4L
N1	N2	N3	N4	N5	N6	N7	N8	N9	N10	N11	N12	N13	N14	N15	N16
I/O33L	I/O34R	I/O33R	PIPE/FTR	VDDQR	VDDQR	Vddql	Vddql	VDDQR	VDDQR	VDDQL	VDDQL	VDD	I/O2L	I/O1R	I/O2R
P1	P2	P3	P4	P5	P6	P7	P8	P9	P10	P11	P12	P13	P14	P15	P16
I/O35R	I/ O 34L	TMS	A 16R ⁽¹⁾	A 13R	A 10R	A 7R	BE1R	BE0R	CLKR	ADSR	A 6R	A 3R	I/OoL	I/O0R	I/O1L
R1	R2	R3	R4	R5	R6	R7	R8	R9	R10	R11	R12	R13	R14	R15	R16
I/O35L	NC	TRST	NC	A 15R	A 12R	A 9R	BE3R	CE0R	R/W R	REPEATR	A 4R	A 1R	OPTR	NC	NC
T1	T2	T3	T4	T5	T6	T7	T8	T9	T10	T11	T12	T13	T14	T15	T16
NC	TCK	NC	NC	A 14R	A 11R	A 8R	BE2R	CE1R	OEr	CNTENR	A 5R	A 2R	A 0R	NC	NC

5617 drw 02d

- 1. A₁₆ is a NC for IDT70V3589.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIH (0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 17mm x 17mm x 1.4mm, with 1.0mm ball-pitch.
- 6. This package code is used to reference the package diagram.
- 7. This text does not indicate orientation of the actual part-marking.

Pin Configuration^(1,2,3,4,5) (con't.)



- 1. A16 is a NC for IDT70V3589.
- 2. All VDD pins must be connected to 3.3V power supply.
- 3. All VDDQ pins must be connected to appropriate power supply: 3.3V if OPT pin for that port is set to VIH (3.3V), and 2.5V if OPT pin for that port is set to VIH (0.0V).
- 4. All Vss pins must be connected to ground supply.
- 5. Package body is approximately 28mm x 28mm x 3.5mm.
- 6. This package code is used to reference the package diagram.



Pin Names

Left Port	Right Port	Names
CEOL, CE1L	CEOR, CE1R	Chip Enables ⁽⁵⁾
R/WL	R/W̄R	Read/Write Enable
ŌĒL	OE R	Output Enable
A0L - A16L ⁽¹⁾	A0R - A16R ⁽¹⁾	Address
I/Ool - I/O35L	1/Oor - 1/O35R	Data Input/Output
CLKL	CLKR	Clock
PL/FTL	PL/FT _R	Pipeline/Flow-Through
ĀDS∟	ĀDS̄R	Address Strobe Enable
CNTENL	<u>CNTEN</u> R	Counter Enable
REPEATL	REPEATR	Counter Repeat ⁽⁴⁾
BEOL - BE3L	BEOR - BE3R	Byte Enables (9-bit bytes) ⁽⁵⁾
VDDQL	VDDQR	Power (I/O Bus) (3.3V or 2.5V) ⁽²⁾
OPTL	OPTr	Option for selecting VDDax ^(2,3)
V	DD	Power (3.3V) ⁽²⁾
V	SS	Ground (0V)
Т	DI	Test Data Input
TI	00	Test Data Output
TO	CK	Test Logic Clock (10MHz)
TN	MS	Test Mode Select
TR	ST	Reset (Initialize TAP Controller)

5617 tbl 01

- 1. A₁₆ is a NC for IDT70V3589.
- VDD, OPTx, and VDDox must be set to appropriate operating levels prior to applying inputs on the I/Os and controls for that port.
- 3. OPTx selects the operating voltage levels for the I/Os and controls on that port. If OPTx is set to VIH (3.3V), then that port's I/Os and controls will operate at 3.3V levels and VDDOX must be supplied at 3.3V. If OPTx is set to VIL (0V), then that port's I/Os and address controls will operate at 2.5V levels and VDDOX must be supplied at 2.5V. The OPT pins are independent of one another—both ports can operate at 3.3V levels, both can operate at 2.5V levels, or either can operate at 3.3V with the other at 2.5V.
- 4. When REPEATx is asserted, the counter will reset to the last valid address loaded via ADSx
- Chip Enables and Byte Enables are double buffered when PL/FT = ViH, i.e., the signals take two cycles to deselect.



<u>Truth Table I—Read/Write and Enable Control</u> (1,2,3,4)

ŌĒ	CLK	Œ	CE1	ΒΕ₃	BĒ ₂	BE ₁	BE₀	R/W	Byte 3 I/O27-35	Byte 2 I/O ₁₈₋₂₆	Byte 1 I/O ₉₋₁₇	Byte 0 I/O ₀₋₈	MODE
Х	1	Н	Х	Χ	Χ	Х	Х	Х	High-Z	High-Z	High-Z	High-Z	Deselected-Power Down
Х	1	Χ	L	Х	Х	Χ	Х	Х	High-Z	High-Z	High-Z	High-Z	Deselected-Power Down
Х	1	L	Н	Н	Н	Н	Н	Х	High-Z	High-Z	High-Z	High-Z	All Bytes Deselected
Х	1	L	Н	Н	Н	Н	L	L	High-Z	High-Z	High-Z	Din	Write to Byte 0 Only
Х	1	L	Н	Н	Н	L	Н	L	High-Z	High-Z	DIN	High-Z	Write to Byte 1 Only
Х	1	L	Η	Н	L	Н	Н	L	High-Z	Din	High-Z	High-Z	Write to Byte 2 Only
Х	1	L	Η	L	Н	Н	Н	L	Din	High-Z	High-Z	High-Z	Write to Byte 3 Only
Х	1	L	Η	Н	Н	L	L	L	High-Z	High-Z	DIN	Din	Write to Lower 2 Bytes Only
Х	↑	L	Η	L	L	Н	Н	L	Din	Din	High-Z	High-Z	Write to Upper 2 bytes Only
Х	\uparrow	L	Η	L	L	L	L	L	DIN	Din	DIN	DIN	Write to All Bytes
L	1	L	Η	Η	Н	Н	L	Н	High-Z	High-Z	High-Z	Dout	Read Byte 0 Only
L	\uparrow	L	Η	Ι	Н	L	Н	Н	High-Z	High-Z	D оит	High-Z	Read Byte 1 Only
L	1	L	Η	Η	L	Н	Н	Н	High-Z	Douт	High-Z	High-Z	Read Byte 2 Only
L	\uparrow	L	Ι	ш	Н	Н	Н	Н	Dоит	High-Z	High-Z	High-Z	Read Byte 3 Only
L	\uparrow	L	Η	Η	Н	L	L	Н	High-Z	High-Z	Dout	Douт	Read Lower 2 Bytes Only
L	1	L	Н	L	L	Н	Н	Н	Dоит	Douт	High-Z	High-Z	Read Upper 2 Bytes Only
L	1	L	Η	L	L	L	L	Н	Dоит	Douт	Douт	Dout	Read All Bytes
Н	1	L	Н	L	L	L	L	Χ	High-Z	High-Z	High-Z	High-Z	Outputs Disabled

NOTES:

5617 tbl 02

- 1. "H" = V_{IH} , "L" = V_{IL} , "X" = Don't Care.
- 2. \overline{ADS} , \overline{CNTEN} , $\overline{REPEAT} = X$.
- 3. $\overline{\text{OE}}$ is an asynchronous input signal.
- 4. It is possible to read or write any combination of bytes during a given access. A few representative samples have been illustrated here.

Truth Table II—Address Counter Control (1,2)

External Address	Previous Internal Address	Internal Address Used	CLK	ĀDS	CNTEN	REPEAT ⁽⁶⁾	I/O ⁽³⁾	MODE
Х	Х	An	1	Χ	Х	L ⁽⁴⁾	Dvo(0)	Counter Reset to last valid ADS load
An	Х	An	1	L ⁽⁴⁾	Х	Н	Dvo (n)	External Address Used
An	Ар	Ар	1	Н	Н	Н	Dvo(p)	External Address Blocked—Counter disabled (Ap reused)
Х	Ар	Ap + 1	1	Н	L ⁽⁵⁾	Н	Dvo(p+1)	Counter Enabled—Internal Address generation

NOTES:

- 1. "H" = V_{IH} , "L" = V_{IL} , "X" = Don't Care.
- 2. Read and write operations are controlled by the appropriate setting of R/ \overline{W} , \overline{CE}_0 , CE₁, \overline{BE}_n and \overline{OE} .
- 3. Outputs configured in flow-through output mode: if outputs are in pipelined mode the date out will be delayed by one cycle.
- 4. ADS and REPEAT are independent of all other memory control signals including CEo, CE1 and BEn
- 5. The address counter advances if $\overline{\text{CNTEN}} = \text{V}_{\text{IL}}$ on the rising edge of CLK, regardless of all other memory control signals including $\overline{\text{CE}}_0$, CE1, $\overline{\text{BE}}_0$.
- 6. When REPEAT is asserted, the counter will reset to the last valid address loaded via ADS. This value is not set at power-up: a known location should be loaded via ADS during initialization if desired. Any subsequent ADS access during operations will update the REPEAT address location.

Recommended Operating Temperature and Supply Voltage⁽¹⁾

Grade	Ambient Temperature	GND	V DD
Commercial	0°C to +70°C	0V	3.3V <u>+</u> 150mV
Industrial	-40°C to +85°C	0V	3.3V <u>+</u> 150mV

NOTES:

1. This is the parameter TA. This is the "instant on" case temperature.

Absolute Maximum Ratings(1)

Symbol	Rating	Commercial & Industrial	Unit
VTERM ⁽²⁾	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
TBIAS ⁽³⁾	Temperature Under Bias	-55 to +125	۰C
Тѕтс	Storage Temperature	-65 to +150	°C
Тли	Junction Temperature	+150	۰C
Іоит	DC Output Current	50	mA

NOTES: 5617 tbl 06

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- 2. VTERM must not exceed VDD + 150mV for more than 25% of the cycle time or 4ns maximum, and is limited to \leq 20mA for the period of VTERM \geq VDD + 150mV.
- 3. Ambient Temperature Under Bias. No AC Conditions. Chip Deselected.

Recommended DC Operating Conditions with VDDQ at 2.5V

Symbol	Parameter	Min.	Тур.	Max.	Unit
VDD	Core Supply Voltage	3.15	3.3	3.45	٧
VDDQ	I/O Supply Voltage ⁽³⁾	2.4	2.5	2.6	٧
Vss	Ground	0	0	0	٧
VIH	Input High Voltage (Address & Control Inputs)	1.7		VDDQ + 100mV ⁽²⁾	V
VIH	Input High Voltage - I/O ⁽³⁾	1.7	-	VDDQ + 100mV ⁽²⁾	٧
VIL	Input Low Voltage	-0.3 ⁽¹⁾	_	0.7	٧

NOTES:

5617 tbl 04

- 5617 tb1 05a
- 1. Undershoot of $Vil \ge -1.5V$ for pulse width less than 10ns is allowed.
- 2. VTERM must not exceed VDDQ + 100mV.
- To select operation at 2.5V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to VIL (OV), and VDDOX for that port must be supplied as indicated above.

Recommended DC Operating Conditions with VDDO at 3.3V

Symbol	Parameter	Min.	Тур.	Мах.	Unit
VDD	Core Supply Voltage	3.15	3.3	3.45	٧
VDDQ	I/O Supply Voltage ⁽³⁾	3.15	3.3	3.45	٧
Vss	Ground	0	0	0	٧
VIH	Input High Voltage (Address & Control Inputs) ⁽³⁾	2.0	_	VDDQ + 150mV ⁽²⁾	V
V⊪	Input High Voltage - I/O ⁽³⁾	2.0	-	VDDQ + 150mV ⁽²⁾	V
VIL	Input Low Voltage	-0.3 ⁽¹⁾	-	0.8	V

5617 tbl 05b

- 1. Undershoot of $V_{IL \ge} -1.5V$ for pulse width less than 10ns is allowed.
- 2. VTERM must not exceed VDDQ + 150mV.
- To select operation at 3.3V levels on the I/Os and controls of a given port, the OPT pin for that port must be set to ViH (3.3V), and VDDOX for that port must be supplied as indicated above.



70V3599/89S

High-Speed 3.3V 128/64K x 36 Dual-Port Synchronous Static RAM

Capacitance⁽¹⁾

 $(TA = +25^{\circ}C, F = 1.0MHz) PQFP ONLY$

Symbol	Parameter	Conditions ⁽²⁾	Max.	Unit
CIN	Input Capacitance	VIN = 3dV	8	pF
Соит ⁽³⁾	Output Capacitance	Vout = 3dV	10.5	pF

5617 tbl

- NOTES:
- 1. These parameters are determined by device characterization, but are not production tested.
- 2. $\overline{\mbox{3dV}}$ references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.
- 3. Cout also references Ci/o.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range ($VDD = 3.3V \pm 150mV$)

			70V35	99/89S	
Symbol	Parameter	Test Conditions	Min.	Max.	Unit
lu	Input Leakage Current ⁽¹⁾	VDDQ = Max., VIN = 0V to VDDQ	_	10	μΑ
llo	Output Leakage Current ⁽¹⁾	\overline{CE}_0 = Vih or CE1 = Vil., Vout = 0V to VDDQ		10	μΑ
Vol (3.3V)	Output Low Voltage ⁽²⁾	IOL = +4mA, $VDDQ = Min$.		0.4	٧
Voh (3.3V)	Output High Voltage ⁽²⁾	IOH = -4mA, VDDQ = Min.	2.4		V
Vol (2.5V)	Output Low Voltage ⁽²⁾	IOL = +2mA, $VDDQ = Min$.	_	0.4	٧
Voн (2.5V)	Output High Voltage ⁽²⁾	IOH = -2mA, VDDQ = Min.	2.0	_	٧

NOTE:

- 1. At $VDD \le 2.0V$ leakages are undefined.
- 2. VDDQ is selectable (3.3V/2.5V) via OPT pins. Refer to p.5 for details.



DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range $^{(3)}$ (VDD = 3.3V \pm 150mV)

						9/89S166 I Only	Co	9/89S133 m'l Ind	
Symbol	Parameter	Test Condition	Versio	on	Typ. ⁽⁴⁾	Max.	Typ. ⁽⁴⁾	Мах.	Unit
IDD	Dynamic Operating	CEL and CER= VIL,	COM'L	S	370	500	320	400	mA
	Current (Both Ports Active)	Outputs Disabled, f = fMAX ⁽¹⁾	IND	S		_	320	480	
ISB1	Standby Current (Both Ports - TTL	CEL = CER = VIH,	COM'L	S	125	200	115	160	mA
	Level Inputs)	Outputs Disabled, f = fMAX ⁽¹⁾	IND	S	_	_	115	195	
ISB2	Standby Current (One Port - TTL	CE"A" = VIL and CE"B" = VIH ⁽⁵⁾	COM'L	S	250	350	220	290	mA
	Level Inputs)	Active Port Outputs Disabled, f=fmAx ⁽¹⁾	IND	S	_	_	220	350	
ISB3	Full Standby Current (Both Ports - CMOS	Both Ports Outputs Disabled \overline{CEL} and $\overline{CER} \ge VDDQ - 0.2V$,	COM'L	S	15	30	15	30	mA
	Level Inputs)	$VIN \ge VDDQ - 0.2V$ or $VIN \le 0.2V$, $f = 0^{(2)}$	IND	S	_	_	15	40	
ISB4	Full Standby Current (One Port - CMOS	$\overline{\text{CE}}$ "A" $\leq 0.2 \text{V}$ and $\overline{\text{CE}}$ "B" $\geq \text{VDDQ} - 0.2 \text{V}^{(5)}$ $\text{VIN} \geq \text{VDDQ} - 0.2 \text{V}$ or $\text{VIN} \leq 0.2 \text{V}$,	COM'L	S	250	350	220	290	mA
	Level Inputs)	Active Port, Outputs Disabled, $f = fMAX^{(1)}$	IND	S			220	350	

NOTES: 5617 tbl 09

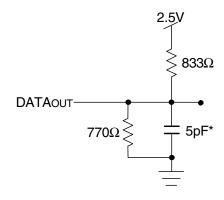
- 2. f = 0 means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- 3. Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- 4. VDD = 3.3V, TA = 25°C for Typ, and are not production tested. IDD DC(f=0) = 120mA (Typ).
- 5. $\overline{CE}x = VIL \text{ means } \overline{CE}_{0X} = VIL \text{ and } CE_{1X} = VIH$
 - $\overline{CE}x = V_{IH} \text{ means } \overline{CE}_{0X} = V_{IH} \text{ or } CE_{1X} = V_{IL}$
 - $\overline{\text{CE}}\text{x} \leq 0.2 \text{V}$ means $\overline{\text{CE}}\text{ox} \leq 0.2 \text{V}$ and $\text{CE}\text{1x} \geq \text{V}\text{DDQ}$ 0.2 V
 - $\overline{\text{CE}}\text{X} \geq \text{V}_{\text{DDQ}}$ 0.2V means $\overline{\text{CE}}_{\text{OX}} \geq \text{V}_{\text{DDQ}}$ 0.2V or CE1x 0.2V
 - "X" represents "L" for left port or "R" for right port.

^{1.} At f = fmax, address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of 1/tcyc, using "AC TEST CONDITIONS" at input levels of GND to 3V.



AC.	Test	Conditions	(VDD0 - 3	31//2	5\/)
\neg	ıcsı	Conditions	(\vee \cup	. S V/Z.	\cup \vee \cup

7 10 1001 0011611110110 (
Input Pulse Levels (Address & Controls)	GND to 3.0V/GND to 2.4V
Input Pulse Levels (I/Os)	GND to 3.0V/GND to 2.4V
Input Rise/Fall Times	2ns
Input Timing Reference Levels	1.5V/1.25V
Output Reference Levels	1.5V/1.25V
Output Load	Figures 1 and 2



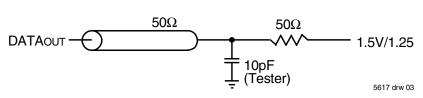


Figure 1. AC Output Test load.

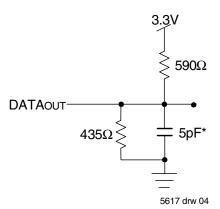


Figure 2. Output Test Load (For tcklz, tckHz, tolz, and toHz). *Including scope and jig.

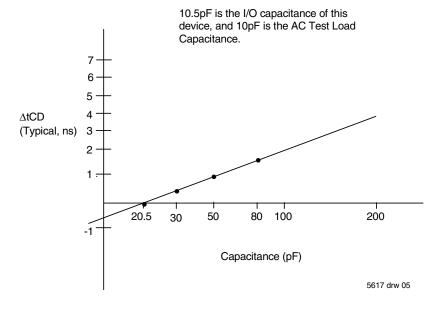


Figure 3. Typical Output Derating (Lumped Capacitive Load).



AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing) $^{(2,3)}$ (VDD = 3.3V ± 150mV)

			70V3599/89S166 Com'l Only		70V3599/89S133 Com'l	
			Г	&	Ind I	
Symbol	Parameter	Min.	Max.	Min.	Max.	Unit
tcyc1	Clock Cycle Time (Flow-Through) ⁽¹⁾	20	_	25		ns
tcyc2	Clock Cycle Time (Pipelined) ⁽¹⁾	6	_	7.5		ns
tcH1	Clock High Time (Flow-Through) ⁽¹⁾	6	_	7	_	ns
tcL1	Clock Low Time (Flow-Through)(1)	6	_	7	_	ns
tch2	Clock High Time (Pipelined) ⁽²⁾	2.1	_	2.6	_	ns
tCL2	Clock Low Time (Pipelined) ⁽¹⁾	2.1	_	2.6	_	ns
tsa	Address Setup Time	1.7	_	1.8	_	ns
tha	Address Hold Time	0.5	_	0.5	_	ns
tsc	Chip Enable Setup Time	1.7	_	1.8	_	ns
thc	Chip Enable Hold Time	0.5	_	0.5	_	ns
tsb	Byte Enable Setup Time	1.7		1.8		ns
tнв	Byte Enable Hold Time	0.5	_	0.5	_	ns
tsw	R/W Setup Time	1.7	_	1.8	_	ns
thw	R/W Hold Time	0.5	_	0.5	_	ns
tsd	Input Data Setup Time	1.7	_	1.8	_	ns
thd	Input Data Hold Time	0.5	_	0.5	_	ns
tsad	ADS Setup Time	1.7	_	1.8	_	ns
thad	ADS Hold Time	0.5	_	0.5	_	ns
tscn	CNTEN Setup Time	1.7	_	1.8	_	ns
thcn	CNTEN Hold Time	0.5	_	0.5	_	ns
tsrpt	REPEAT Setup Time	1.7	_	1.8	_	ns
thrpt	REPEAT Hold Time	0.5	_	0.5	_	ns
toe	Output Enable to Data Valid		4.0	_	4.2	ns
tolz	Output Enable to Output Low-Z	1	_	1	_	ns
tонz	Output Enable to Output High-Z	1	3.6	1	4.2	ns
tcD1	Clock to Data Valid (Flow-Through) ⁽¹⁾		12	_	15	ns
tCD2	Clock to Data Valid (Pipelined) ⁽¹⁾		3.6	_	4.2	ns
toc	Data Output Hold After Clock High	1	_	1	_	ns
tckhz	Clock High to Output High-Z	1	3	1	3	ns
tcklz	Clock High to Output Low-Z	1	_	1	_	ns
Port-to-Port [elay					
tco	Clock-to-Clock Offset	5		6	_	ns

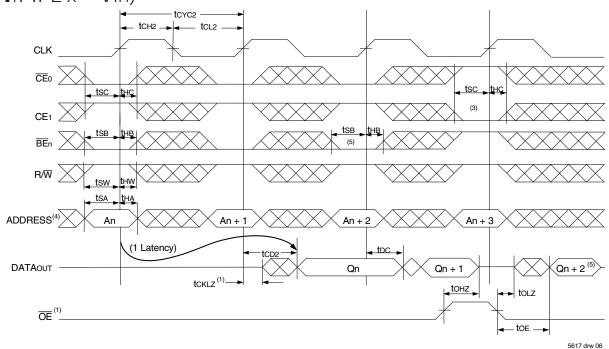
NOTES

^{1.} The Pipelined output parameters (tcvc2, tcb2) apply to either or both left and right ports when FT/PIPEx = ViH. Flow-through parameters (tcvc1, tcb1) apply when FT/PIPE = ViL for that port.

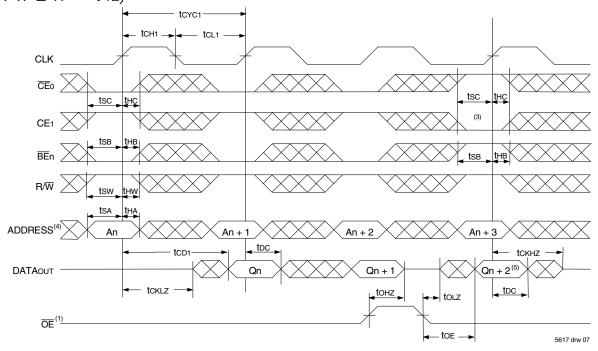
^{2.} All input signals are synchronous with respect to the clock except for the asynchronous Output Enable (OE) and FT/PIPE. FT/PIPE should be treated as a DC signal, i.e. steady state during operation.

^{3.} These values are valid for either level of VDDQ (3.3V/2.5V). See page 5 for details on selecting the desired operating voltage levels for each port.

Timing Waveform of Read Cycle for Pipelined Operation $(\mathbf{FT}/PIPE'x' = VIH)^{(2)}$

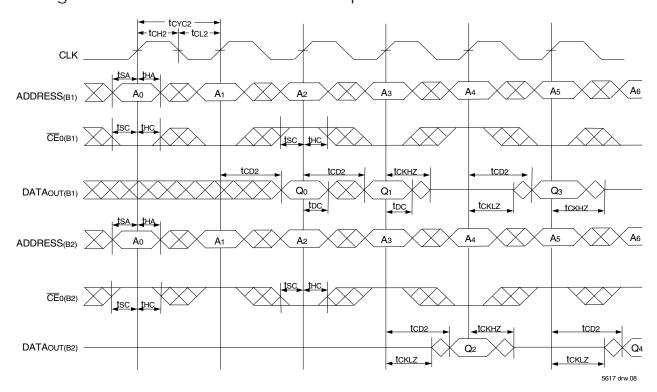


Timing Waveform of Read Cycle for Flow-through Output $(\overline{FT}/PIPE"x" = VIL)^{(2,6)}$

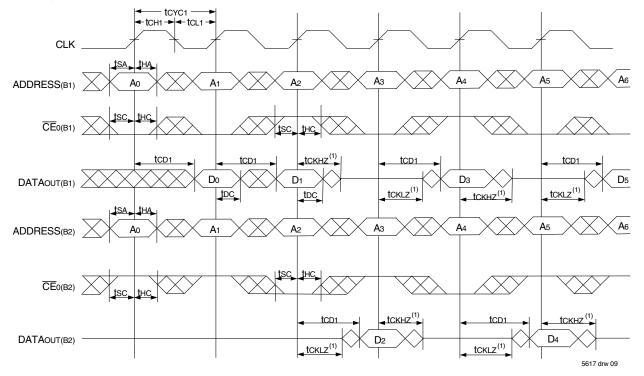


- 1. $\overline{\text{OE}}$ is asynchronously controlled; all other inputs are synchronous to the rising clock edge.
- 2. $\overline{ADS} = V_{IL}$ and $\overline{REPEAT} = V_{IH}$.
- The output is disabled (High-Impedance state) by \(\overline{CE}_0 = V_{IH}\), \(\overline{CE}_1 = V_{IL}\), \(\overline{BE}_n = V_{IH}\) following the next rising edge of the clock. Refer to Truth Table 1.
- 4. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 5. If BEn was HIGH, then the appropriate Byte of DATAout for Qn + 2 would be disabled (High-Impedance state).
- 6. "x" denotes Left or Right port. The diagram is with respect to that port.

Timing Waveform of a Multi-Device Pipelined Read (1,2)



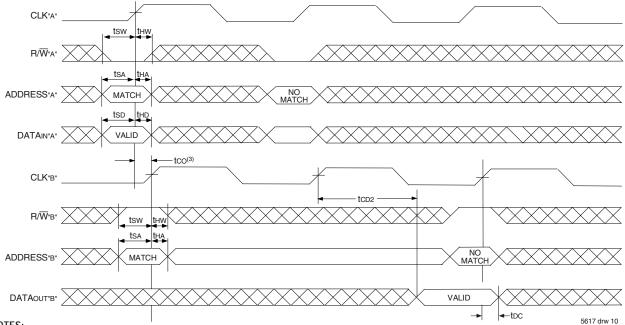
Timing Waveform of a Multi-Device Flow-Through Read^(1,2)



- B1 Represents Device #1; B2 Represents Device #2. Each Device consists of one IDT70V3599/89 for this waveform, and are setup for depth expansion in this example. ADDRESS(B1) = ADDRESS(B2) in this situation.
- 2. \overline{BEn} , \overline{OE} , and $\overline{ADS} = VIL$; $\overline{CE1(B1)}$, $\overline{CE1(B2)}$, $\overline{R/W}$ and $\overline{REPEAT} = VIH$.



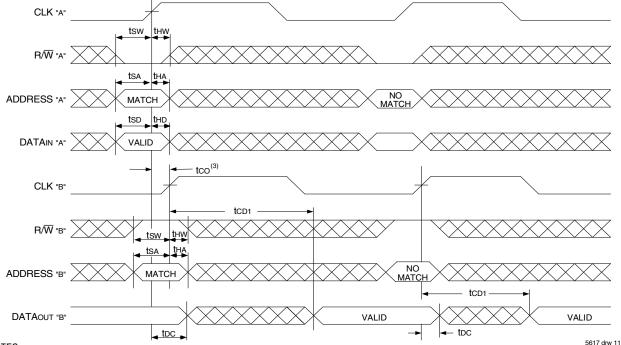
Timing Waveform of Left Port Write to Pipelined Right Port Read (1,2,4)



NOTES:

- 1. $\overline{\text{CE}}_0$, $\overline{\text{BE}}_n$, and $\overline{\text{ADS}}$ = V_{IL}; CE₁ and $\overline{\text{REPEAT}}$ = V_{IH}.
- 2. \overline{OE} = V_{IL} for Port "B", which is being read from. \overline{OE} = V_{IH} for Port "A", which is being written to.
- 3. If tco ≤ minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (ie, time from write to valid read on opposite port will be tco + 2 tcyc2 + tcp2). If tco > minimum, then data from Port "B" read is available on first Port "B" clock cycle (ie, time from write to valid read on opposite port will be tco + tcyc2 + tcp2).
- 4. All timing is the same for Left and Right ports. Port "A" may be either Left or Right port. Port "B" is the opposite of Port "A"

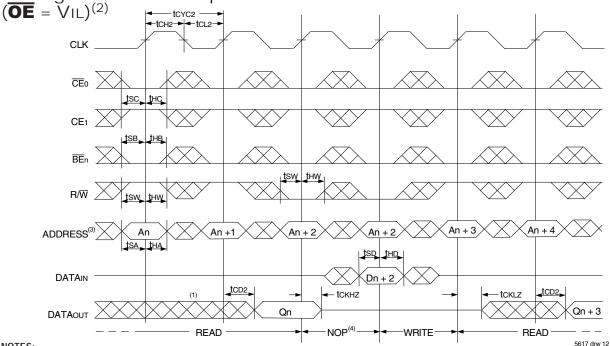
Timing Waveform with Port-to-Port Flow-Through Read (1,2,4)



- 1. \overline{CE}_0 , \overline{BE}_n , and $\overline{ADS} = VIL$; CE_1 and $\overline{REPEAT} = VIH$.
- 2. \overline{OE} = VIL for the Right Port, which is being read from. \overline{OE} = VIH for the Left Port, which is being written to.
- 3. If tco ≤ minimum specified, then data from Port "B" read is not valid until following Port "B" clock cycle (i.e., time from write to valid read on opposite port will be tco + tcyc + tcp1). If tco > minimum, then data from Port "B" read is available on first Port "B" clock cycle (i.e., time from write to valid read on opposite port will be tco + tcp1).
- 4. All timing is the same for both left and right ports. Port "A" may be either left or right port. Port "B" is the opposite of Port "A".

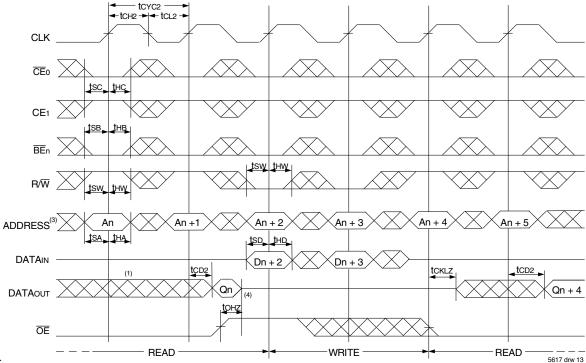


Timing Waveform of Pipelined Read-to-Write-to-Read



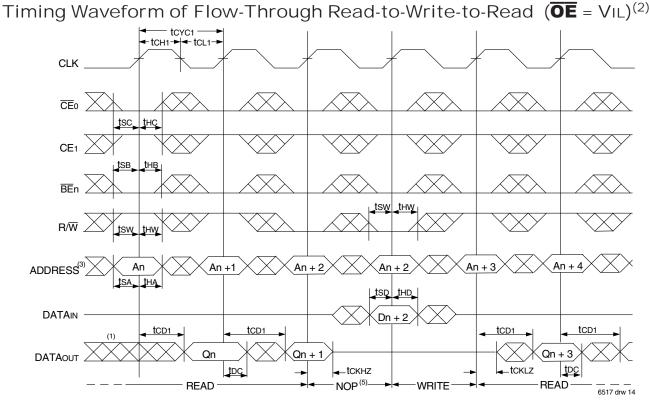
- Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- CEo, BEn, and ADS = VIL; CE1 and REPEAT = VIH. "NOP" is "No Operation".
- 3. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.

Timing Waveform of Pipelined Read-to-Write-to-Read (**OE** Controlled)⁽²⁾

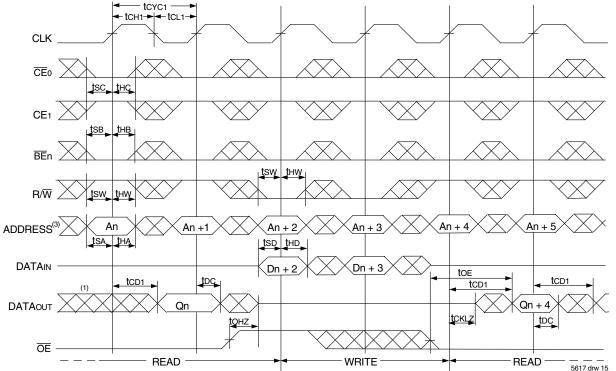


- 1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- \overline{CE}_0 , \overline{BE}_n , and $\overline{ADS} = VIL$; CE1 and $\overline{REPEAT} = VIH$.
- 3. Addresses do not have to be accessed sequentially since ADS = VIL constantly loads the address on the rising edge of the CLK; numbers are for reference
- This timing does not meet requirements for fastest speed grade. This waveform indicates how logically it could be done if timing so allows.





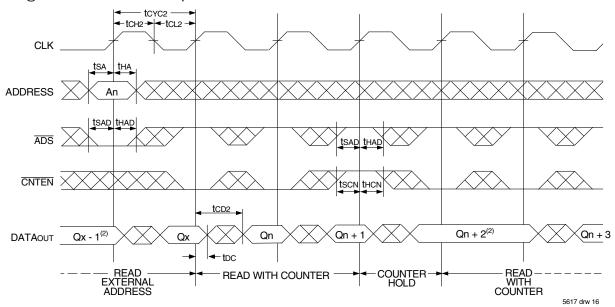
Timing Waveform of Flow-Through Read-to-Write-to-Read (**OE** Controlled)⁽²⁾



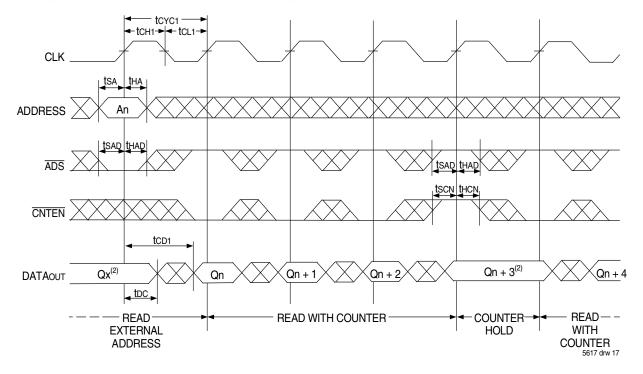
- 1. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 2. $\overline{\text{CE}}_0$, $\overline{\text{BE}}_n$, and $\overline{\text{ADS}}$ = VIL; CE1 and $\overline{\text{REPEAT}}$ = VIH.
- 3. Addresses do not have to be accessed sequentially since $\overline{ADS} = V_{IL}$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 4. "NOP" is "No Operation." Data in memory at the selected address may be corrupted and should be re-written to guarantee data integrity.



Timing Waveform of Pipelined Read with Address Counter Advance⁽¹⁾

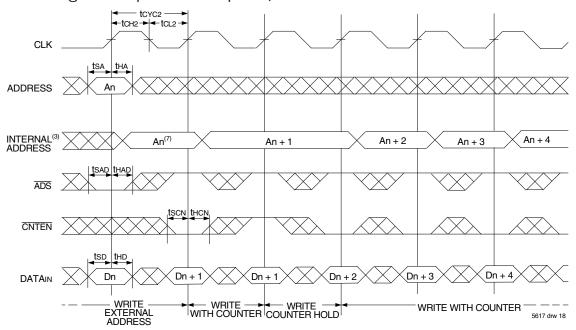


Timing Waveform of Flow-Through Read with Address Counter Advance⁽¹⁾

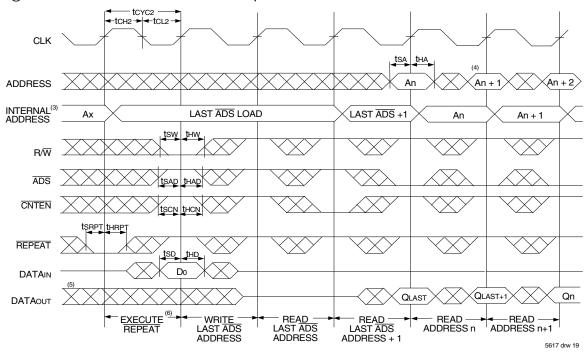


- 1. \overline{CE}_0 , \overline{OE} , $\overline{BE}_n = V_{IL}$; CE1, R/ \overline{W} , and $\overline{REPEAT} = V_{IH}$.
- 2. If there is no address change via $\overline{ADS} = VIL$ (loading a new address) or $\overline{CNTEN} = VIL$ (advancing the address), i.e. $\overline{ADS} = VIH$ and $\overline{CNTEN} = VIH$, then the data output remains constant for subsequent clocks.

Timing Waveform of Write with Address Counter Advance (Flow-through or Pipelined Inputs)⁽¹⁾



Timing Waveform of Counter Repeat⁽²⁾



- 1. $\overline{CE_0}$, $\overline{BE_n}$, and $R/\overline{W} = V_{IL}$; CE_1 and $\overline{REPEAT} = V_{IH}$.
- 2. \overline{CE}_0 , $\overline{BE}_n = VIL$; $CE_1 = VIH$.
- 3. The "Internal Address" is equal to the "External Address" when \overline{ADS} = VIL and equals the counter output when \overline{ADS} = VIH.
- 4. Addresses do not have to be accessed sequentially since $\overline{ADS} = VIL$ constantly loads the address on the rising edge of the CLK; numbers are for reference use only.
- 5. Output state (High, Low, or High-impedance) is determined by the previous cycle control signals.
- 6. No dead cycle exists during REPEAT operation. A READ or WRITE cycle may be coincidental with the counter REPEAT cycle: Address loaded by last valid ADS load will be accessed. Extra cycles are shown here simply for clarification. For more information on REPEAT function refer to Truth Table II.
- 7. CNTEN = V_{IL} advances Internal Address from 'An' to 'An +1'. The transition shown indicates the time required for the counter to advance. The 'An +1'Address is written to during this cycle.

Functional Description

The IDT70V3599/89 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide minimal set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal, however, the self-timed internal write pulse is independent of the LOW to HIGH transition of the clock signal.

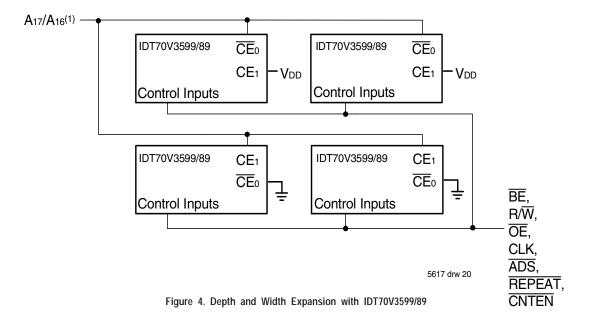
An asynchronous output enable is provided to ease asynchronous bus interfacing. Counterenable inputs are also provided to stall the operation of the address counters for fast interleaved memory applications.

A HIGH on $\overline{\text{CE}}$ oor a LOW on CE1 for one clock cycle will power down the internal circuitry to reduce static power consumption. Multiple chip enables allow easier banking of multiple IDT70V3599/89s for depth expansion configurations. Two cycles are required with $\overline{\text{CE}}$ 0 LOW and CE1 HIGH to re-activate the outputs.

Depth and Width Expansion

The IDT70V3599/89 features dual chip enables (refer to Truth Table I) in order to facilitate rapid and simple depth expansion with no requirements for external logic. Figure 4 illustrates how to control the various chip enables in order to expand two devices in depth.

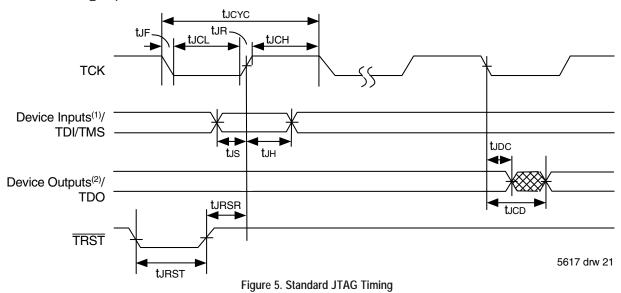
The IDT70V3599/89 can also be used in applications requiring expanded width, as indicated in Figure 4. Through combining the control signals, the devices can be grouped as necessary to accommodate applications needing 72-bits or wider.



NOTE

1. A₁₇ is for IDT70V3599, A₁₆ is for IDT70V3589.

JTAG Timing Specifications



NOTES:

- 1. Device inputs = All device inputs except TDI, TMS, and TRST.
- 2. Device outputs = All device outputs except TDO.

JTAG AC Electrical Characteristics^(1,2,3,4)

		70V3599/89		9
Symbol	Parameter	Min.	Max.	Units
ticyc	JTAG Clock Input Period	100		ns
исн	JTAG Clock HIGH	40		ns
tucı	JTAG Clock Low	40		ns
tur	JTAG Clock Rise Time		3 ⁽¹⁾	ns
₩F	JTAG Clock Fall Time		3 ⁽¹⁾	ns
URST	JTAG Reset	50		ns
tursr	JTAG Reset Recovery	50		ns
tico	JTAG Data Output	_	25	ns
tudo	JTAG Data Output Hold	0		ns
tus	JTAG Setup	15		ns
tлн	JTAG Hold	15	_	ns

NOTES:

- 1. Guaranteed by design.
- 2. 30pF loading on external output signals.
- 3. Refer to AC Electrical Test Conditions stated earlier in this document.
- 4. JTAG operations occur at one speed (10MHz). The base device may run at any speed specified in this datasheet.



Identification Register Definitions

Instruction Field	Value	Description
Revision Number (31:28)	0x0	Reserved for version number
IDT Device ID (27:12)	0x0312 ⁽¹⁾	Defines IDT part number
IDT JEDEC ID (11:1)	0x33	Allows unique identification of device vendor as IDT
ID Register Indicator Bit (Bit 0)	1	Indicates the presence of an ID register

NOTE:

5617 tbl 13

Scan Register Sizes

Register Name	Bit Size
Instruction (IR)	4
Bypass (BYR)	1
Identification (IDR)	32
Boundary Scan (BSR)	Note (3)

5617 tbl 14

System Interface Parameters

Instruction	Code	Description
EXTEST	0000	Forces contents of the boundary scan cells onto the device outputs ⁽¹⁾ . Places the boundary scan register (BSR) between TDI and TDO.
BYPASS	1111	Places the bypass register (BYR) between TDI and TDO.
IDCODE	0010	Loads the ID register (IDR) with the vendor ID code and places the register between TDI and TDO.
HIGHZ	0011	Places the bypass register (BYR) between TDI and TDO. Forces all device output drivers to a High-Z state.
SAMPLE/PRELOAD	0001	Places the boundary scan register (BSR) between TDI and TDO. SAMPLE allows data from device inputs ⁽²⁾ to be captured in the boundary scan cells and shifted serially through TDO. PRELOAD allows data to be input serially into the boundary scan cells via the TDI.
RESERVED	All other codes	Several combinations are reserved. Do not use codes other than those identified above.

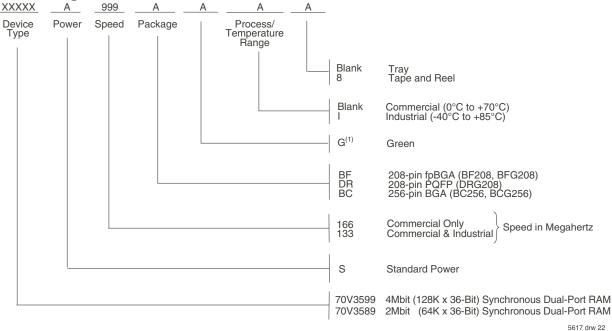
NOTES:

- 1. Device outputs = All device outputs except TDO.
- 2. Device inputs = All device inputs except TDI, TMS, and $\overline{\text{TRST}}$.
- 3. The Boundary Scan Descriptive Language (BSDL) file for this device is available on the IDT website (www.idt.com), or by contacting your local IDT sales representative.

^{1.} Device ID for IDT70V3589 is 0x0313.



Ordering Information XXXXX 999



NOTE:

1. Green parts available. For specific speeds, packages and powers contact your local sales office. LEAD FINISH (containing SnPb) are obsolete excluding BGA and Hermetic packages. Note; the information regarding recently obsoleted parts is included in this datasheet for customer convenience. Please see the Orderable Parts Table for the current, active part list.

ORDERABLE PART INFORMATION

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
133	70V3599S133BC	BC256	CABGA	С
	70V3599S133BC8	BC256	CABGA	С
	70V3599S133BCGI	BCG256	CABGA	I
	70V3599S133BCI	BC256	CABGA	I
	70V3599S133BCl8	BC256	CABGA	I
	70V3599S133BF	BF208	CABGA	С
	70V3599S133BF8	BF208	CABGA	С
	70V3599S133BFGI	BFG208	CABGA	I
	70V3599S133BFGl8	BFG208	CABGA	I
	70V3599S133BFI	BF208	CABGA	I
	70V3599S133BFI8	BF208	CABGA	I
	70V3599S133DRGI	DRG208	PQFP	I
166	70V3599S166BC	BC256	CABGA	С
	70V3599S166BC8	BC256	CABGA	С
	70V3599S166BCG	BCG256	CABGA	С
	70V3599S166BF	BF208	CABGA	С
	70V3599S166BF8	BF208	CABGA	С
	70V3599S166BFG	BFG208	CABGA	С
	70V3599S166BFG8	BFG208	CABGA	С
	70V3599S166DRG	DRG208	PQFP	С

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
133	70V3589S133BC	BC256	CABGA	С
	70V3589S133BC8	BC256	CABGA	С
	70V3589S133BCI	BC256	CABGA	1
	70V3589S133BCl8	BC256	CABGA	1
	70V3589S133BF	BF208	CABGA	С
	70V3589S133BF8	BF208	CABGA	С
	70V3589S133BFI	BF208	CABGA	1
	70V3589S133BFl8	BF208	CABGA	1
	70V3589S133DRG	DRG208	PQFP	С
	70V3589S133DRGI	DRG208	PQFP	1
166	70V3589S166BC	BC256	CABGA	С
	70V3589S166BC8	BC256	CABGA	С
	70V3589S166BCG	BCG256	CABGA	С
	70V3589S166BF	BF208	CABGA	С
	70V3589S166BF8	BF208	CABGA	С
	70V3589S166BFG	BFG208	CABGA	С
	70V3589S166BFG8	BFG208	CABGA	С
	70V3589S166DRG	DRG208	PQFP	С



Datasheet Document History:

06/02/00:		Initial Public Offering
07/12/00:		Added mux to functional block diagram
07/30/01:	Page 20	Changed maximum value for JTAG AC Electrical Characteristics for tuch from 20ns to 25ns
	Page 9	Added Industrial Temperature DC Parameters
11/20/01:	Pages 2, 3 & 4	Added date revision for pin configurations
	Page 11	Changed to Evalue in AC Electrical Characteristics, please refer to Errata #SMEN-01-05
	Pages 1 & 22	Replaced тм logo with ® logo
	Page 10	Changed AC Test Conditions Input Rise/Fall Times
07/01/02:		Consolidated multiple devices into one datasheet
	Pages 1 & 5	Added DCD capability for Pipelined Outputs
	Page 7	Clarified TBIAS and added TJN
	Page 9	Changed DC Electrical Parameters
	Page 11	Removed Clock Rise & Fall Time from AC Electrical Characteristics Table
		Removed Preliminary status
05/19/03:	Page 11	Added Byte Enable SetupTime & Byte Enable Hold Time to AC Electrical Characteristics Table
	Page 22	Added IDT Clock Solution Table
01/10/06:	Page 1	Added green availability to features
	Page 5	Changed footnote 2 for Truth Table I from \overline{ADS} , \overline{CNTEN} , $\overline{REPEAT} = VIH to \overline{ADS}, \overline{CNTEN}, \overline{REPEAT} = XIH to ADS, $
	Page 22	Added green indicator to ordering information
07/25/08:	Page 9	Corrected a typo in the DC Chars table
01/19/09:	Page 22	Removed "IDT" from orderable part number
07/26/10:	Page 11	In order to correct the header notes of the AC Elect Chars Table and align them with the Industrial temprange values located in the table, the commercial TA header note has been removed
	Pages 13-16	In order to correct the footnotes of timing diagrams, <u>CNTEN</u> has been removed to reconcile the footnotes with the <u>CNTEN</u> logic definition found in Truth Table II - Address Counter Control
10/14/14:	Page 22	Added Tape & Reel to Ordering Information
06/21/18:		Product Discontinuation Notice - PDN# SP-17-02
		Last time buy expires June 15, 2018
03/07/19:	Pages 1, 22	Added orderable part information table. Updated EOL note to obsolete status.
11/05/19:	Pages 2 - 4	Updated package codes
	Page 4	Rotated DRG208 TQFP pin configuration to accurately reflect pin 1 orientation
	Page 23	Deleted IDT Clock Solution table

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